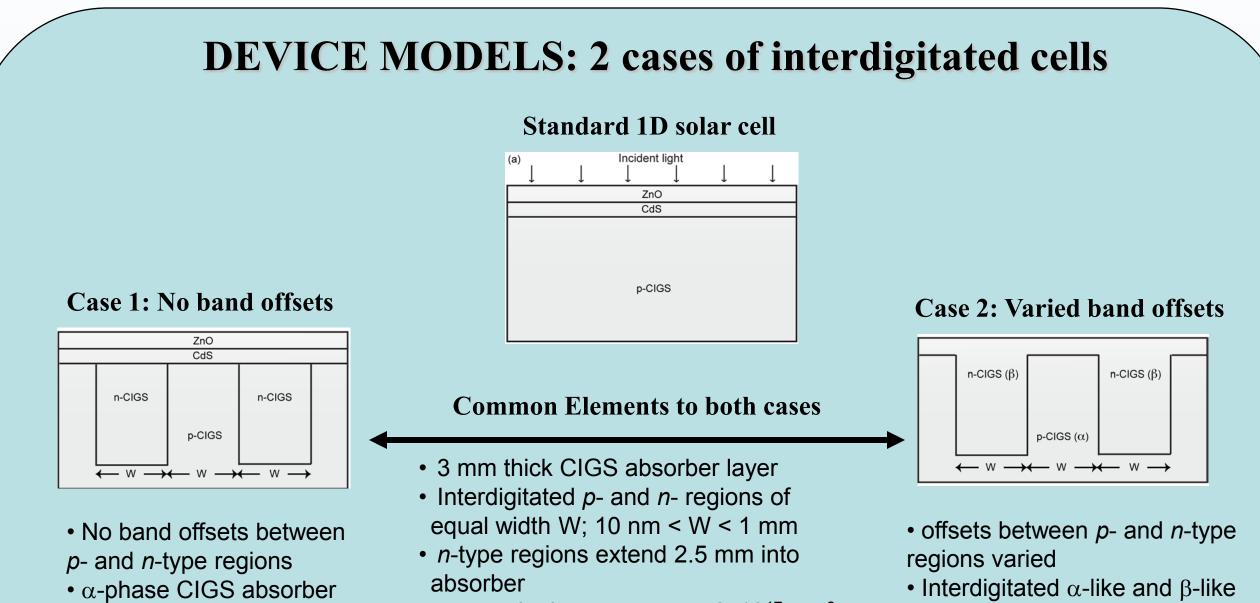
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Device Physics of Nanoscale Interdigitated Solar Cells

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MOTIVATION

- Nanoscale interdigitated solar cell device architectures are being investigated for organic and inorganic solar cell devices.
- Due to the inherent complexity of these device designs quantitative modeling is needed to understand the device physics.
- Theoretical concepts have been proposed that nanodomains of different phases may form in polycrystalline CIGS solar cells.
- These theories propose that the nanodomains may form complex 3D intertwined *p-n* networks that enhance device performance.
- Recent experimental evidence offers some support for the existence of nanodomains in CIGS thin films.
- This study utilizes CIGS solar cells to examine general and CIGS-specific concepts in nanoscale interdigitated solar cells.

Material Parameters				
Bulk Properties	ZnO	CdS	α-CIGS	β-CIGS
E _g (eV)	3.3	2.4	1.15	1.43
χ (eV)	4.6	4.6	4.6	4.62
μ _e (cm²/V-s)	100	100	100/10	100/10
μ _h (cm²/V-s)	25	25	12.5/1.25	12.5/1.25
<i>n</i> , <i>p</i> (cm ⁻³)	n: 10 ¹⁸	n: 6.0x10 ¹⁷	varied	varied
ε/ε ₀	9	10	13.6	13.6
m _e /m _o	0.2	0.2	0.09	0.09
m _h /m _o	1.2	0.8	0.72	0.72
Midgap state (cm⁻³)	N _a : 10 ¹⁶	N _a : 10 ¹⁶	N _o : 1x10 ¹⁵	N _o : 1x10 ¹⁵
σ_{e} (cm ²)	10 ⁻¹⁶	10 ⁻¹⁵	2x10 ^{-14/-13}	2x10 ^{-14/-13}
$\sigma_{\rm h}$ (cm ²)	10 ⁻¹³	10 ⁻¹²	2x10 ^{-14/-13}	2x10 ^{-14/-13}
Surface Properties	Front	Back		
S _e (cm/s)	10 ⁷	10 ⁷		
S _h (cm/s)	10 ⁷	10 ⁷		
Reflectivity	0.05	0		

COMPUTATIONAL APPROACH

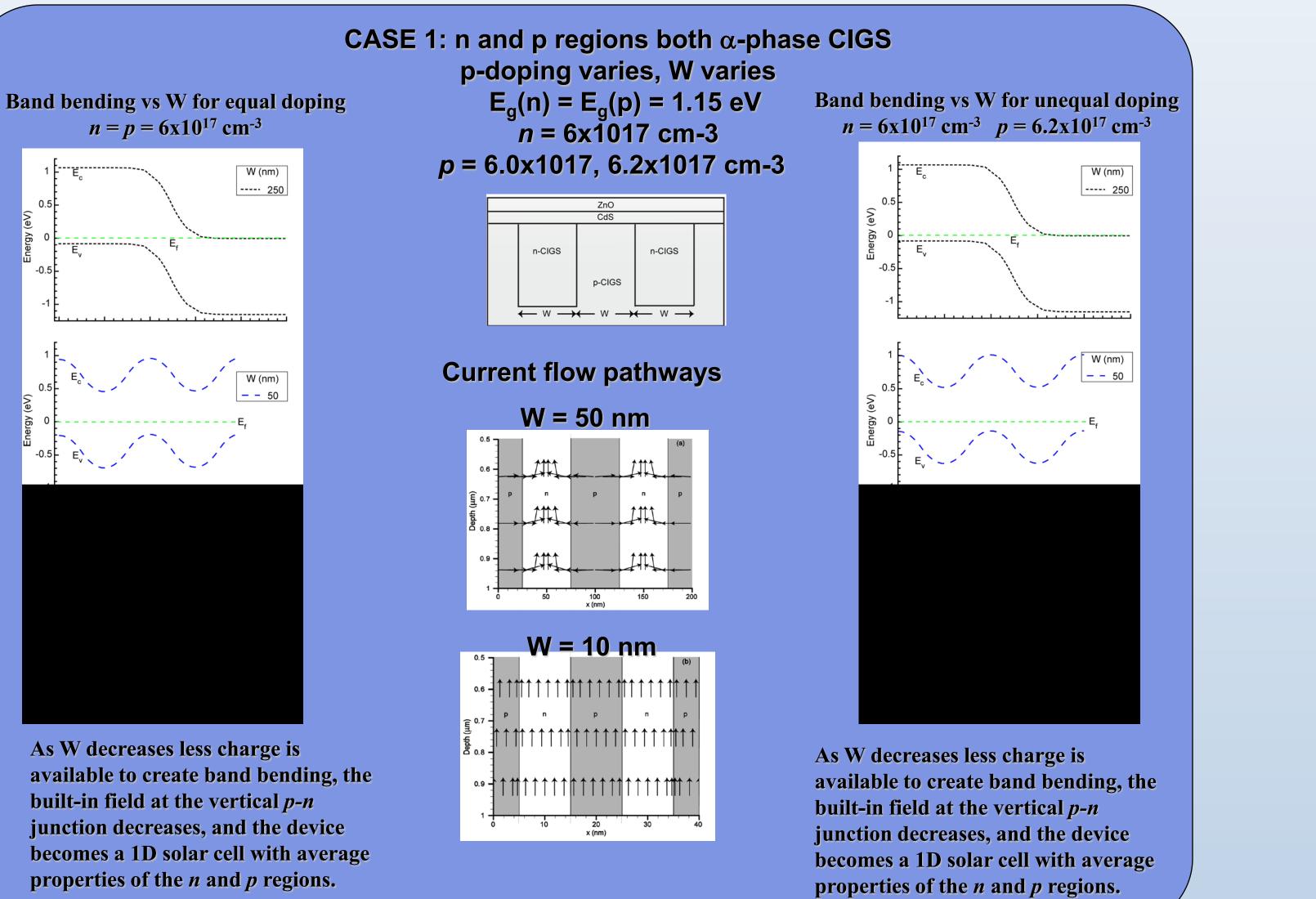
• Device performance was calculated by solving the Poisson and electron-hole continuity equations using the drift-diffusion model and by solving current and energy density boundary equations at heterointerfaces described by the Anderson model.

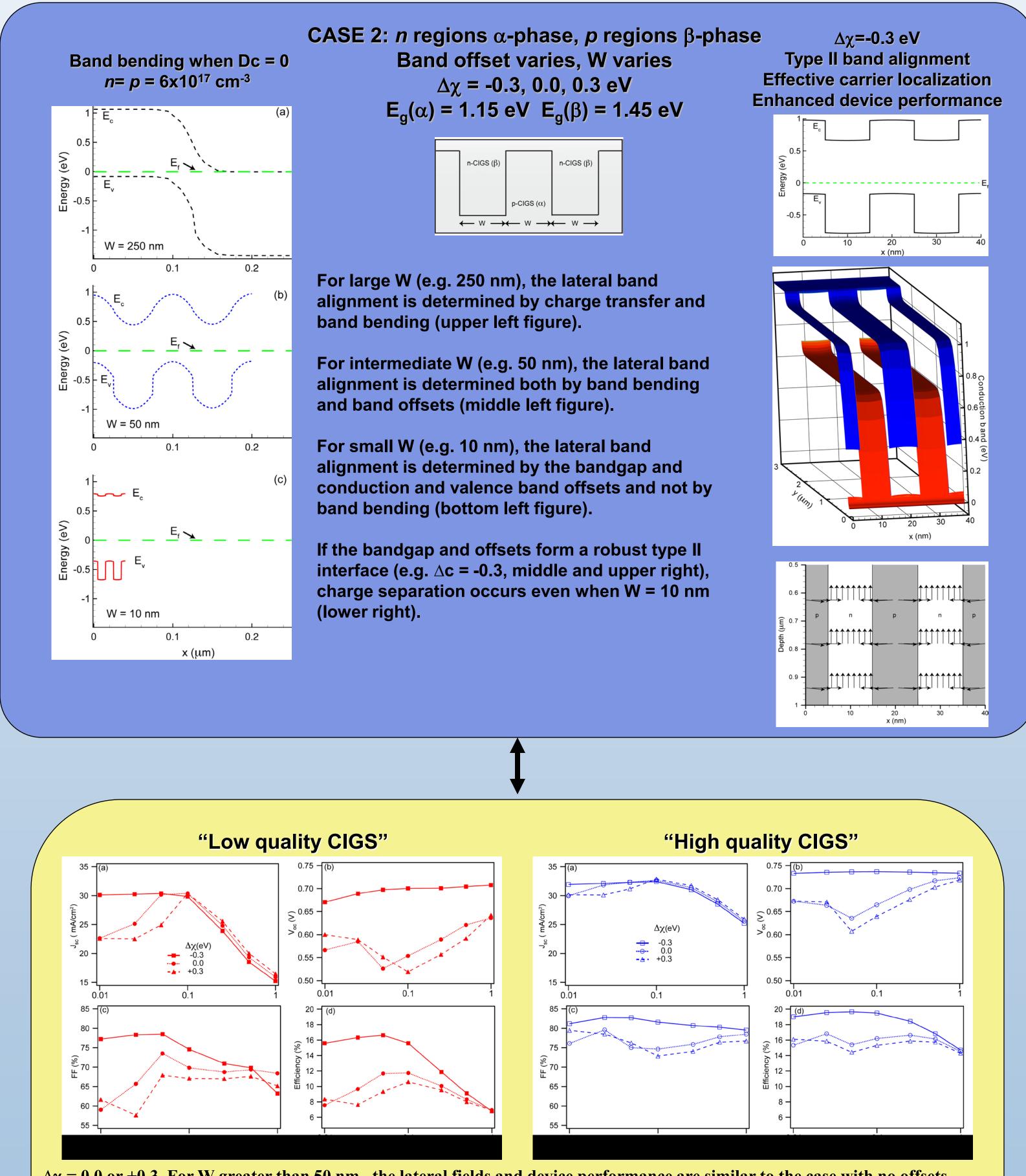
• emitter = 50 nm *n*-CdS and 200 nm ZnO

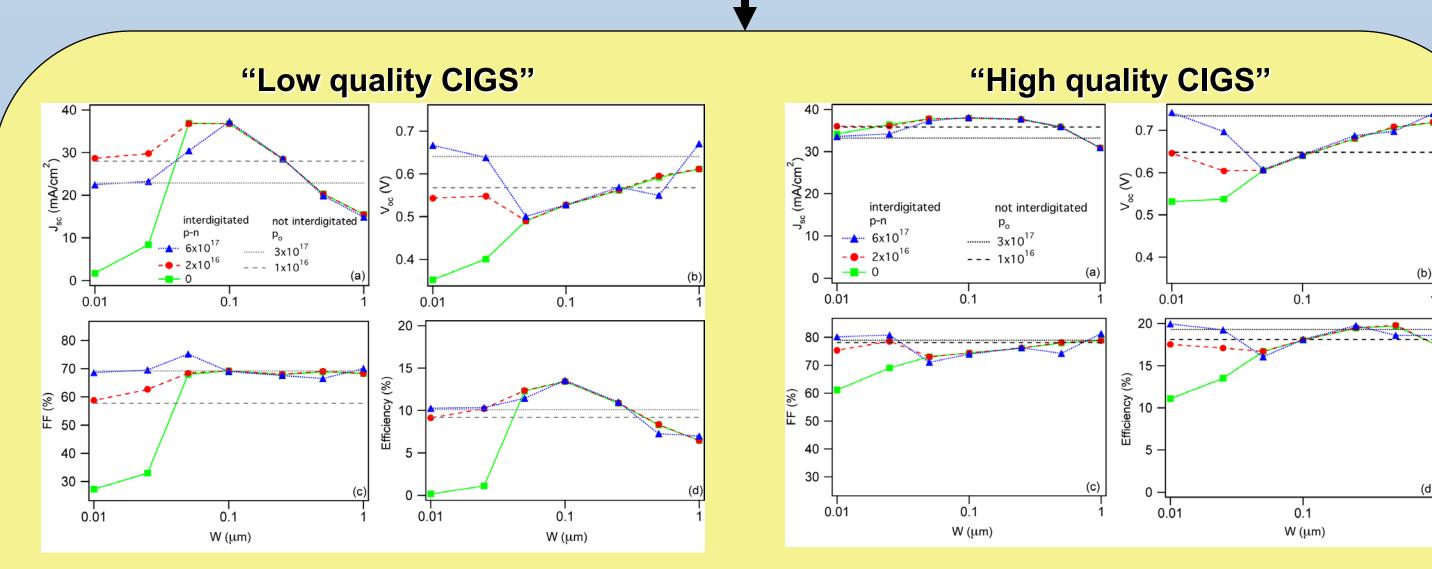
• *n*-type doping constant at 6x10¹⁷ cm⁻³ phase CIGS p-type doping varied from 6x10¹⁷ cm⁻³ to 1.2x10¹⁸ cm⁻³ Device performance calculated for 'high quality' and 'low quality' CIGS absorber

• emitter = 50 nm *n*-CdS

• Programming was done within the Sentaurus Device simulation environment.







- V_{oc} is optimum when there is maximal band bending and minimal dark current, which occurs at large W. W = 1 umBut the geometry is not ideal for current collection and J_{sc} is inferior to a comparable planar junction device.
- W-> 50 nm As W decreases towards 50 nm, current is collected more efficiently, but increasing dark current and reduced band bending lower V_{oc} . PV designs that increase photocurrent collection generally increase dark current too.
- W < 50 nm The strength of the lateral fields diminish and no longer effectively separate charge. Transport and performance becomes identical to a planar junction device with a uniform doping equivalent to half of p - n in the CIGS layer.

 $\Delta \chi = 0.0$ or +0.3 For W greater than 50 nm, the lateral fields and device performance are similar to the case with no offsets. For W less than 50 nm, either the valence or conduction band is flat. Hence one carrier is not separated laterally and recombination is not effectively reduced,. The results are again similar to the case with no offsets.

For large W, the lateral fields and device performance are similar to the case with no offsets. However as W is $\Delta \chi = -0.3$ reduced, the offsets form a robust type II junction which effectively separates charge and reduces recombination even for W = 10 nm. This structure improves device performance relative to a planar junction device, and atttains efficiencies greater than 15% even for "low quality" material with a diffusion length of 100 nm.



• Interdigitated thin-film solar cells can give good device performance commensurate with comparable planar junction devices.

• Interdigitated *p* and *n* regions increase efficiency relative to a comparable planar junction device for low-quality material when W is about 50 or 100 nm in this study.

In most cases, device performance is generally not significantly increased relative to a planar junction.

Performance can be increased for low and high quality material when the band offsets between *n* and *p*-type material form a robust type-II band alignment that effectively separates electrons and holes even when W is small.

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